Specification	AXIOM95LP	Rev.: 1	Date: 2014-04-30

Oscillator type: VHF OCXO in Low Profile Connectorized Package

Parameter	min.	typ.	max.	Unit	Condition
Frequency range	80		130	MHz	
Standard frequencies	80.000/95.000/96.000 100.000/125.000/128.000			MHz	
Frequency stability					
Initial tolerance @ +25°C			±300	ppb	V_C @ centre value
vs. operating temperature range	Option 3 & 4 See tables 2 & 3				steady state
vs. supply voltage variation (pushing)			±10	ppb	V_S ±5%
vs. load change (pulling)			±10	ppb	R_L ±10%
Long term (aging) per day (after 30 days operation) (Note 2)			±10 ±2	ppb ppb	AT-Cut SC-Cut
Long term (aging) 1st year (after 30 days operation) (Note 2)		±300 ±50	±500 ±200	ppb ppb	AT-Cut SC-Cut
Frequency adjustment range					
Electronic Frequency Control (EFC)	±2 ±1		±5	ppm ppm	AT-Cut SC-Cut
EFC voltage V_C	0.25	2.5	4.75	V	
EFC slope ($\Delta f / \Delta V_C$)	Positive				
EFC input impedance	100			kΩ	
RF output					
Signal waveform	Sine wave				
Load R_L	50			Ω	±10%
Output level (Note 3)	+3			dBm	
Harmonics			-30	dBc	
Spurious			-90	dBc	
Warm-up time @ +25°C		3	5	min	$\Delta f_{final}/f_0$ < ±0.1 ppm
Phase Noise	Consult factory				
Supply voltage V_S	4.75 11.4	5.0 12.0	5.25 12.6	V V	Option 2 = "50" Option 2 = "12"
Current consumption (steady state) @ +25°C (Note 4)			250 150	mA mA	Option 2 = "50" Option 2 = "12"
Current consumption (warm-up) (Note 4)			600 350	mA mA	Option 2 = "50" Option 2 = "12"
Enclosure (see drawing) (LxWxH)	54.0x40.0x13.0 max.			mm	Option 1 (see Table 1)
Weight			50	g	
Packing	Palette				

Notes:

1. Terminology and test conditions are according to IEC60679-1 and MIL-PRF-55310, unless otherwise stated
2. Lower aging on request
3. Other output level on request
4. May be higher for wide operating temperature range

Absolute Maximum Ratings

Parameter	min.	max.	Unit	Condition
Supply Voltage V_S	-0.5	V_S + 10%	V	V_S to GND
Control Voltage V_C	-0.5	15	V	V_C to GND
Storage Temperature	-55	+125	°C	

Package option

Option 1	Package*
A	Default (see Drawing 1)
B	Mounting plate rotated by 90° (see Drawing 2)

Table 1 ***SMA connector on request**

Frequency stability vs. temperature

Option 3	Stability [ppb]
05	±5
10	±10
25	±25
50	±50
100	±100
200	±200

Table 2

Lower Temperature		Upper Temperature	
Option 4	T [°C]	Option 4	T [°C]
0	0	A	+50
1	-10	B	+60
2	-20	C	+70
3	-30	D	+75
4	-40	E	+80
5	-55	F	+85

Table 3 **Standard: "1B" = -10°C to +60°C**

Temperature range [°C]	Frequency stability [Option 3]					
	05	10	25	50	100	200
0 ~ +50	O	SC	SC	AT	AT	AT
-10 ~ +60	O	SC	SC	AT	AT	AT
-20 ~ +70	O	SC	SC	SC	AT	AT
-30 ~ +70	O	O	SC	SC	SC	AT
-40 ~ +75	O	O	SC	SC	SC	SC
-40 ~ +85	O	O	O	SC	SC	SC
-55 ~ +85	-	O	O	SC	SC	SC

Table 4 "Availability" **AT, SC = AT-Cut, SC-Cut available, O = available on request, - not available**

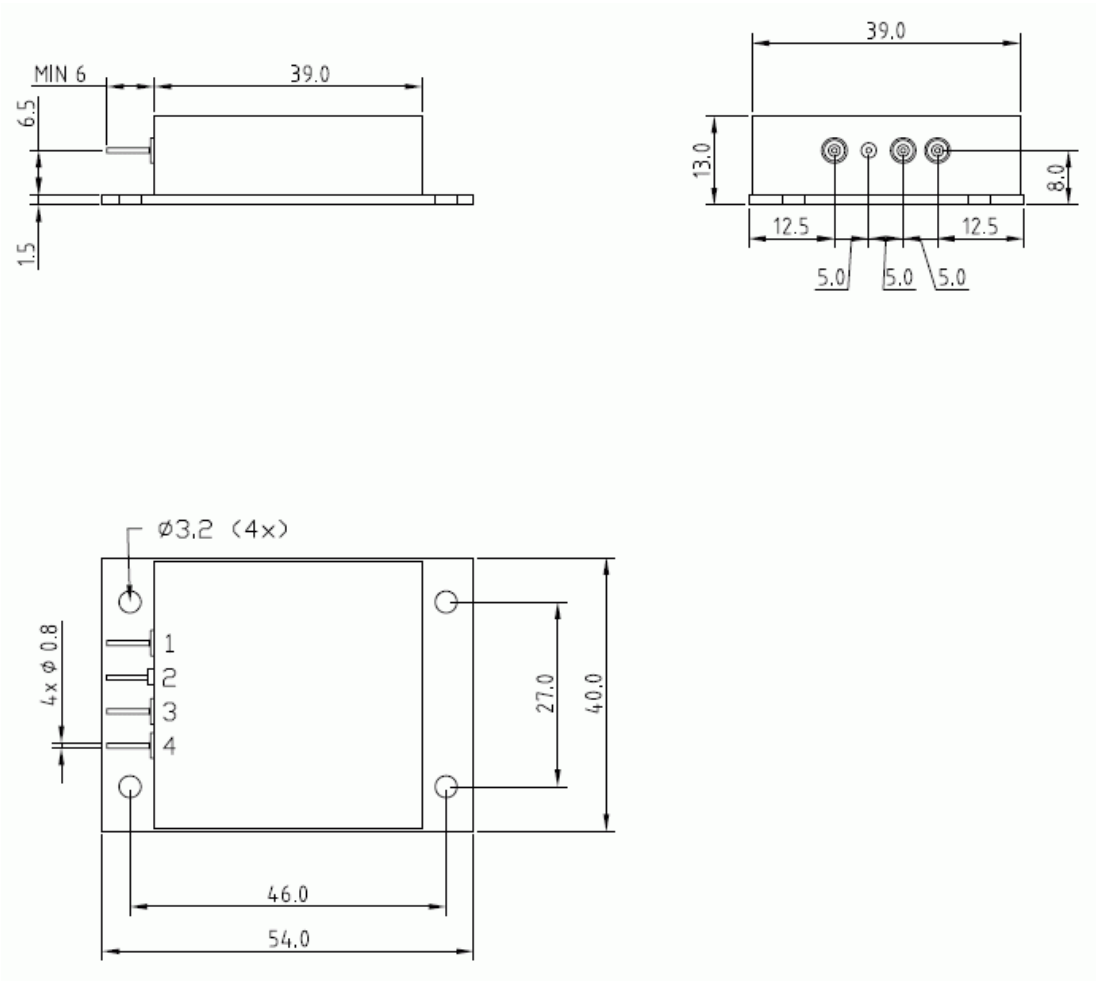
Ordering Code

Model	Option 1 [Package]	Option 2 [Supply Voltage]	Option 3 [Stability]	Option 4 [Temperature range]	Revision	Frequency [MHz]
AXIOM95LP	Table 1	12, 50	Table 2	Table 3	Rev.1	125.000

Example: AXIOM95LP-A-12-100-1B_Rev.1 – 125.000 MHz

Enclosure drawing

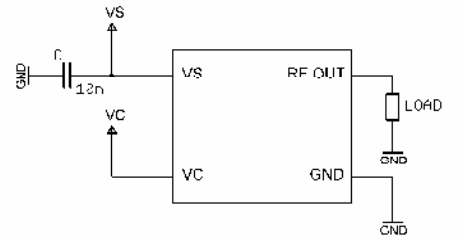
Package Option A:



Drawing 1 "Default"

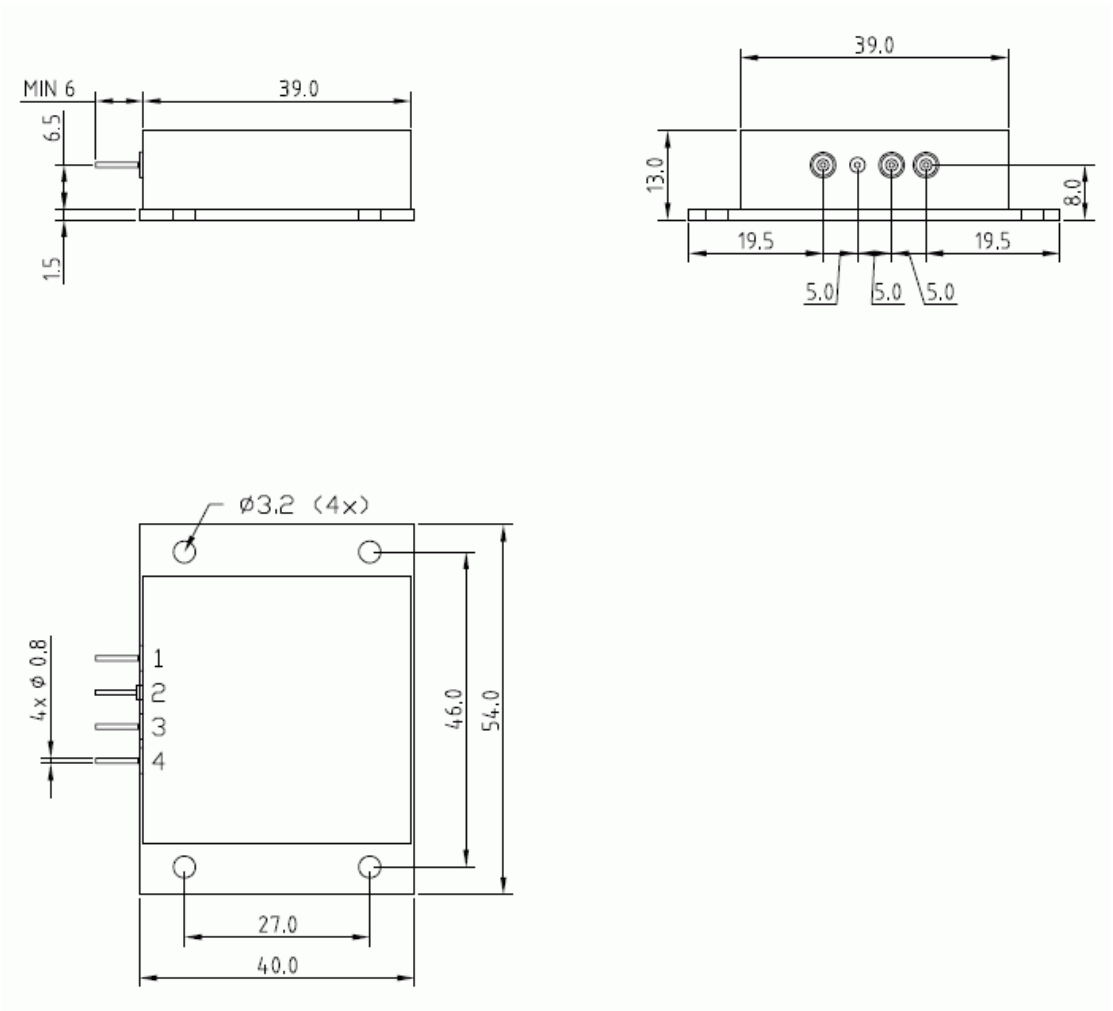
Pin connections (both options)

Pin#	Symbol	Function
1	RF OUT	RF Output
2	GND	Ground
3	V_C	Control Voltage (EFC)
4	V_S	Supply Voltage



* See Application Note AXAN-011

Package Option B:



Drawing 2 "Mounting plate 90° rotated"

Handling and Testing

Parameter	Procedure	Source
Handling and Testing	Application Note AXAN-011	www.axtal.com
Processing	Application Note AXAN-012	www.axtal.com

Parameter	Procedure		Condition
Electrostatic discharge (ESD)			
THD devices	IEC60749-26	HBM	2000 V
SMD devices	IEC60749-27	MM	200 V
Washable	✖ Yes ☐ No		
RoHS- Compliant	✖ Yes ☐ No		

Environmental conditions

Test	IEC 60068 Part …	IEC 60679-1 Clause	MIL-STD-202G Method	MIL-STD-810F Method	MIL-PRF-55310D Clause	Test conditions (IEC)
Sealing tests (if applicable)	2-17	5.6.2	112E		3.6.1.2	Gross leak: Test Qc, Fine leak: Test Qk
Solderability Resistance to soldering heat	2-20 2-58	5.6.3	208H 210F		3.6.52 3.6.48	Test Ta Method 1 Test Td_1 Method 2 Test Td_2 Method 2
Shock*	2-27	5.6.8	213B	516.4	3.6.40	Test Ea, 3 x per axes 100g, 6 ms half-sine pulse
Vibration, sinusoidal*	2-6	5.6.7.1	201A 204D	516.4-4	3.6.38.1 3.6.38.2	Test Fc, 30 min per axes, 10 Hz - 55 Hz 0,75mm; 55 Hz - 2 kHz, 10g
Vibration, random*	2-64	5.6.7.3	214A	514.5	3.6.38.3 3.6.38.4	Test Fdb
Endurance tests - ageing - extended aging		 5.7.1 5.7.2	108A		 4.8.35	 30 days @ 85°C, OCXO @25°C 1000h, 2000h, 8000h @85°C

Other environmental conditions on request

Data sheet is for information purposes only and may be subject to modifications or may be discontinued without notice.

Revision History

Rev.	Drawing	Date [dd.mm.yyyy]	Remarks	Author	Checked
1	D0	30.04.2014	First issue	HH	HH